PATENT

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What is claimed is:

1. A process for depositing a low dielectric constant film, comprising reacting a cyclic organosiloxane with oxygen in the presence of RF power in a chamber at a pressure of between about 2.5 Torr and about 10 Torr, wherein the oxygen is introduced into the chamber at a flowrate less than or equal to the flowrate of the cyclic organosiloxane into the chamber.

- 2. The process of claim 1, wherein the cyclic organosiloxane is selected from the group consisting of 1,3,5,7-tetramethylcyclotetrasiloxane, octamethylcyclotetrasiloxane, 1,3,5,7,9-pentamethylcyclopentasiloxane, 1,3,5,7-tetrasilano-2,6-dioxy-4,8-dimethylene, 2,4,6-trisilanetetrahydropyran, and 2,5-disilanetetrahydrofuran.
- 3. The process of claim 1, wherein the cyclic organosiloxane is octamethylcyclotetrasiloxane.
- 4. The process of claim 1, wherein the oxygen is introduced into the chamber at a flowrate of about 100 sccm to about 200 sccm.
- 5. The process of claim 1, further comprising introducing a carrier gas into the chamber.
- 6. The process of claim 1, wherein a carrier gas is introduced into the chamber at a flow rate between about 0 sccm and about 1000 sccm.
- 7. A process for depositing a low dielectric constant film, comprising reacting a cyclic organosiloxane with oxygen in the presence of mixed frequency RF power in a chamber at a pressure of between about 2.5 Torr and about 10 Torr, wherein the oxygen is introduced into the chamber at a flowrate less than or equal to the flowrate of the cyclic organosiloxane into the chamber.

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8. The process of claim 7, wherein the cyclic organosiloxane is selected from the group consisting of 1,3,5,7-tetramethylcyclotetrasiloxane, octamethylcyclotetrasiloxane, 1,3,5,7,9-pentamethylcyclopentasiloxane, 1,3,5,7-tetrasilano-2,6-dioxy-4,8-dimethylene, 2,4,6-trisilanetetrahydropyran, and 2,5-disilanetetrahydrofuran.

- The process of claim 7, wherein the cyclic organosiloxane is octamethylcyclotetrasiloxane.
- 10. The process of claim 7, wherein the oxygen is introduced into the chamber at a flowrate of about 100 sccm to about 200 sccm.
- 11. The process of claim 7, wherein the mixed frequency RF power comprises a high frequency power of 13.56 MHz and a low frequency RF power of about 350 KHz to 1 MHz.
- 12. The process of claim 11, wherein the high frequency power is delivered at between about 10 W and about 1000 W and the low frequency power is delivered at between about 0 W and about 500 W.
- 13. The process of claim 11, wherein the high frequency power is delivered at between about 300 W and about 1000 W.
- 14. The process of claim 7, further comprising introducing a carrier gas into the chamber at a flowrate between about 0 sccm and about 1000 sccm.
- 15. A process for depositing a low dielectric constant film, comprising reacting octamethylcyclotetrasiloxane with oxygen in the presence of mixed frequency RF power in a chamber at a pressure of between about 2.5 Torr and about 10 Torr, wherein the oxygen is introduced into the chamber at a flowrate less than or equal to

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the flowrate of the octamethylcyclotetrasiloxane into the chamber, and the oxygen flowrate is less than or equal to about 200 sccm.

- 16. The process of claim 15, wherein the oxygen flowrate is about 100 sccm to about 200 sccm.
- 17. The process of claim 15, wherein the oxygen flowrate is about 100 sccm.
- 18. The process of claim 15, wherein the mixed frequency RF power comprises a high frequency power of 13.56 MHz and a low frequency RF power of about 350 KHz to 1 MHz.
- 19. The process of claim 18, wherein the high frequency power is delivered at between about 300 W and about 1000 W.
- 20. The process of claim 15, further comprising introducing a carrier gas into the chamber.